Search Notes				

Application/Control No.	Applicant(s)/Patent unde Reexamination	er
10/809,378	KISHI ET AL.	
Examiner	Art Unit	
Sophia S. Chen	2852	

	SEARCHED				
Class	Subclass	Date	Examiner		
399	67, 69, 70, 320, 88, 37	10/12/2005	sc		
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INTERFERENCE SEARCHED				
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